The Synergistic Effect of Phosphonic and Carboxyl Acid Groups for Efficient and Stable Perovskite Solar Cells

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Abstract: Reducing the interfacial defects between the perovskite/electron transport layer (ETL) is the key point to improving the efficient and stable performance of perovskite solar cells (PSCs). In this study, two self-assembled molecules ((aminomethyl)phosphonic acid and glycine) with different functional groups (phosphonic acid (-H2PO3) and carboxylic acid (-COOH)) were mixed to form the buried bottom interface of PSCs. The synergistic effect of -H2PO3 with its higher anchoring ability and -COOH with its fast carrier transport improved the performance of PSCs. Additionally, the SnO2 modified by mixed self-assembly molecules (M-SAM) showed a more appropriate energy level alignment, favoring charge transport and minimizing energy loss. In addition, the amine group (-NH2) on the two small molecules effectively interacted with uncoordinated Pb2+ in perovskite and improved the quality of the perovskite films. Consequently, the (FAPbI3)0.992(MAPbBr3)0.008 PSCs with M-SAM reached a PCE of 24.69% (0.08 cm2) and the perovskite modules achieved a champion efficiency of 18.57% (12.25 cm2 aperture area). Meanwhile, it still maintained more than 91% of its initial PCE after being placed in nitrogen atmosphere at 25 °C for 1500 h, which is better than that of the single-SAM and control devices. Further reference is provided for the future commercialization of perovskite with efficient and stable characteristics.

Keywords: interface passivation; anchoring; charge transfer; self-assembled small molecule; large area

1. Introduction

Planar perovskite solar cells (PSCs) have gradually been considered to be a commercially promising device due to their small current–voltage hysteresis, high power conversion efficiency and simple preparation process [1–3]. In the past decade, the power conversion efficiency (PCE) of PSCs has increased from 3.8% to 26.1% [4–6]. The electron transport layer (ETL) in the typical n-i-p structure has electron-selective contact with the perovskite absorption layer. Concurrently, the upper surface of the ETL also affects the number of nucleation points and the grain growth of the absorption layer, and ETLs with low-defect concentrations are of decisive significance for improving the performance of PSCs devices [7,8]. The commonly reported ETLs in the n-i-p structure are titanium oxide (TiO2) and tin oxide (SnO2). However, compared with TiO2, the SnO2 substrate has the potential for the best ETL due to its high-electron mobility and easy preparation.

The common preparation methods of SnO2 when used as electron transport layer mainly include spin-coated SnO2 nanocrystals and chemical bath deposition (CBD) of SnO2. Different from the spin-coated SnO2 method, the SnO2 film prepared via CBD is more compact and uniform. Moreover, the CBD method is not limited by the size of substrate and is more beneficial to the future commercial development of PSCs [9]. However, there are hydroxyl (-OH) and oxygen vacancy (OV) defects on the surface of SnO2 film prepared via...
CBD, which significantly increase the non-radiative recombination of the ETL/Perovskite interface, thus changing the performance of PSCs and accelerating their degradation [10]. At the same time, a large number of defects on the ETL/perovskite layer interface are not conducive to the energy level matching of the charge transfer, and lead to serious non-radiative recombination at the interface [11,12]. In order to solve these problems, researchers have made many attempts which can be divided into SnO$_2$ body passivation and surface passivation. For body passivation, it has been reported that the addition of phosphonate ethanolamine (PE) to the aqueous colloid of SnO$_2$ can significantly reduce the number of Sn dangling bonds in SnO$_2$, which is beneficial for improving the electrical properties of SnO$_2$. At the same time, the amino group (-NH$_2$) of PE can interact with the uncoordinated Pb$^{2+}$ in the perovskite active layer, further inhibiting interface defects and improving device performance [13]. However, some researchers have tried to passivate or modify the surface defects of SnO$_2$ to reduce the interface defects between SnO$_2$ and perovskite [12]. It has been reported that the use of ultraviolet ozone to improve the surface wettability of SnO$_2$ while reducing surface defects can achieve a champion efficiency of 17.21%. Some researchers have also reported that the use of KCl aqueous solution to modify the surface of SnO$_2$ can passivate the surface defects of SnO$_2$ to improve the performance of the device, and finally achieve a champion efficiency of 22.2%. At the same time, using some self-assembled molecules with anchoring groups to passivate the interface is also an effective interface passivation strategy [14]. It has been reported that an anchoring group with strong bonding strength not only shortens the assembly adsorption time and improves the uniformity of adsorption distribution, but also makes the carrier transporting layers (CTL) have a high compatibility with the deposition of the active layer of the perovskite device, thus greatly reducing interface defects [15]. Yang et al. studied a series of self-assembled molecules (SAM) with carboxylic acid groups (-COOH), such as benzoic acid, 3-aminopropionic acid, etc., and found that appropriate interface interactions can significantly reduce the density of defect states and promote charge extraction and transfer at the interface, which increases the efficiency by about 10% compared with solar cells without SAMs, and investigated different chemical interactions between SnO$_2$/perovskite [16]. Although small molecules containing -COOH have excellent electron transport capacities due to their special structure, their binding energy on the surface of SnO$_2$ is low [17–19]. The widely used anchoring group, which is similar to -COOH and has similar anchoring ability, is the phosphonic group (-H$_2$PO$_3$) [13,20,21]. Its binding energy on the surface of SnO$_2$ is much larger than that of the -COOH. Unfortunately, due to the geometric shape and conjugate loss of -H$_2$PO$_3$, the charge transfer rate of the -H$_2$PO$_3$ is not competitive with that of -COOH [22]. In addition, it has been reported that the amino group (-NH$_2$) contained in the small molecule has the effect of interacting with the uncoordinated Pb$^{2+}$ in the perovskite, which can effectively decrease interface defects [13,23]. Sargent et al. combined ammonium fluoride with CBD-SnO$_2$ and found that -NH$_2$ could reduce the surface defect sites and match energy levels better with perovskite. This strategy showed a PCE of 23.3% and a higher open circuit voltage ($V_{OC}$) [20]. Meanwhile, the application of CBD SnO$_2$ to a large area also reflects the problem of non-uniformity. Although CBD SnO$_2$ has more commercial potential than spin-coated SnO$_2$ nanocrystals, the uniform passivation of SnO$_2$ defects is also a problem that must be solved first. Lin et al. developed a simple post-treatment method using periodic acid to modify the SnO$_2$ film and increased the proportion of tin oxide (IV) with the help of periodic acid. Consequently, the 3 × 3 cm$^2$ perovskite modules with a champion efficiency of 18.10% were shown [24]. Therefore, a strategy that can not only effectively passivate the surface defects of SnO$_2$ but also serve as a reference for large-scale commercialization is needed.

In this study, two self-assembled molecules ((aminomethyl)phosphonic acid and glycine) with similar molecular structures but different anchoring groups (phosphonic acid (-H$_2$PO$_3$) and carboxylic acid (-COOH)) were used as interlayers in SnO$_2$/perovskite. Phosphonic acid groups have a stronger anchoring ability on the surface of metal oxides than carboxylic acid groups due to their unique structure, while carboxylic acid groups...
have their unique characteristics of rapid charge transfer. The different anchoring groups can meet the requirements of the buried bottom interface for carrier transport (-COOH) and anchoring ability (-H₂PO₃), so as to solve the defect problem of single functional group. Photovoltaic performance may be further improved by using the complementary advantages of the two groups while improving the anchoring capacity and charge transfer. In addition, the same partial amine group (-NH₂) on the two small molecules effectively interact with uncoordinated Pb²⁺ in the perovskite layer, which can decrease interface defects. The energy level between SnO₂ and the perovskite layers was further adjusted by mixed self-assembly molecules (M-SAM). Finally, the PCE of PSC was increased from 22.72% to 24.69% (0.08 cm²) and the V_OC was increased from 1.12 V to 1.16 V. Meanwhile, the stability of the device modified by M-SAM was significantly improved, which maintained more than 91% of its initial PCE after 1500 h and 100 h placed at 25 °C and 65 °C in nitrogen atmosphere. In addition, the 4 × 4 cm² (12.25 cm² aperture area) perovskite modules achieved the best efficiency of 18.57%. This study demonstrates an effective strategy for passivating the surface of SnO₂, which improves the PCE of PSCs while taking into account stability. This complementary synergistic passivation strategy provides a simple and effective method for future high-performance and durable commercial devices.

2. Experimental Section

Materials. Hydrochloric acid (HCl, 37 wt.% in water) was purchased from Sinopharm (Shanghai, China). SnCl₂·2H₂O (≥99.98%) and urea (≥99.0%), thioglycolic acid (TGA, ≥99.0%), chlorobenzene (CB, ≥99.9%), isopropanol (IPA, ≥99.9%) and acetonitrile (≥99.9%) were purchased from Sigma-Aldrich (Shanghai China). Dimethyl sulfoxide (DMSO) (≥99.9%), and dimethylformamide (DMF) (≥99.9%) were purchased from Alfa Aesar (Shanghai China). FAI (≥99.5%), PbI₂ (99.99%), MAPbBr₃ (≥99.5%), MACl (≥99.5%), PEAI (≥99.5%), Spiro-OMeTAD (≥99.8%), 4-tert-Butylpyridine (tBP, ≥96%), Co-TFSI salt (≥99.5%) and Li-TFSI salt (≥99.5%) were purchased from Xi’an Polymer Technology Corp (Xi’an, China). (Aminomethyl)phosphonic acid (≥98%) and glycine (99%) were purchased from Adamas (Shanghai China).

CBD SnO₂. The SnO₂ layer was deposited on the surface of FTO by chemical bath deposition (CBD). The CBD solution was prepared by mixing 5.625 g of urea, 1.2375 g of SnCl₂·2H₂O, 5.625 mL of HCl, 112.5 μL of TGA, and 450 mL of deionized water (DI water). The FTO substrates and the CBD solution were loaded into a glass reaction vessel and reacted at 94 °C in an oil bath for 5.5 h. Then, the SnO₂-deposited FTO were removed from the reaction vessel and cleaned via sonication with DI water and ethanol for 10 min each.

Preparation of perovskite solution. The perovskite precursor solution was prepared by mixing 1.4 M FAI, 1.53 M PbI₂, 0.5 M MACl, and 0.8 mol% MAPbBr₃ in 1 mL mixture solvent (volume ratio, DMF:DMSO = 8:1).

Device fabrication. The FTO/SnO₂ substrates were annealed at 170 °C for 60 min and treated with UV-Ozone for 20 min. Then the FTO/SnO₂ substrate was immersed in a small molecule aqueous solution for 20 min, then dried with nitrogen, and finally placed in a 100 °C hot stage for annealing for 5 min. The prepared FTO FTO/SnO₂/SAM were transferred to the glove box. The perovskite film was spin-coated on the substrates at 1000 rpm for 10 s, and 5000 rpm for 30 s, and chlorobenzene was dripped at 20 s after starting, then annealed at 100 °C for 60 min. For the 2D perovskite passivation, PEAI (15 mM in IPA) was deposited at 5000 rpm for 30 s. For HTL, the 25 μL Spiro-OMeTAD solution was spin-coated on the perovskite layer at 3800 rpm for 30s. The Spiro-OMeTAD solution was prepared by dissolving 101.92 mg of Spiro-OMeTAD, 24.4 μL Li-TFSI salt (520 mg·L⁻¹ in acetonitrile solution), 49.6 μL FK209 salt (300 mg·in 1 mL acetonitrile solution), and 45.4 μL tBP solution in 1 mL chlorobenzene. Finally, 100 nm of Au was deposited via thermal evaporation.
3. Results and Discussion

The electrostatic surface potential (ESP) diagram and structural formula of P-SAM and C-SAM are shown in Figure 1a and Figure S1, respectively. The dipole moment value of P-SAM (2.11 D) was higher than that of C-SAM (1.66 D). The dipole moment can reflect the polarity of the molecule, and it is easy to obtain the relative level of the van der Waals force of the two molecules; thus, P-SAM was more easily anchored on the surface of SnO\(_2\) than C-SAM was. Figure 1b shows a flowchart of the preparation of the buried bottom interface. The glass/FTO/SnO\(_2\) substrate was immersed in a M-SAM aqueous solution with a volume ratio of 1:1 (1 mM in deionized water) for 20 min, and we then used N\(_2\) to blow away the residual solution on the surface of SnO\(_2\), and annealed it at 100 °C for 5 min. Meanwhile, this immersion method using SAM has the potential to be applied to a large area. The perovskite films on SnO\(_2\), SnO\(_2\)/P-SAM, SnO\(_2\)/C-SAM and SnO\(_2\)/M-SAM were characterized by scanning electron microscopy (SEM) and X-ray diffraction (XRD). It is evident from Figures 1c–f and S2 that the average grain size of perovskite films was similar, but the grain boundary was improved after M-SAM modification (Figures S2a–d and S3). Meanwhile, this method is also applicable to large areas; Figures S4 and S5 show M-SAM, as a buried interface, can enhance the uniformity of perovskite grains. The enhanced hydrophilicity of the SnO\(_2\)/SAM films (Figure S3) from -NH\(_2\) in SAM molecules are helpful for the deposition of perovskite precursor solutions and the growth of better-quality perovskite films, which is consistent with the SEM results [25]. The XRD spectra in Figure 1g show that the perovskite films with an M-SAM interlayer have stronger crystallinity, which indicates that M-SAM regulates crystallinity.

![Figure 1](image_url)

**Figure 1.** (a) ESP map of P-SAM (Left) and C-SAM (Right). (b) Diagram of the preparation work of M-SAM. SEM of perovskite films, (c) pristine SnO\(_2\), (d) SnO\(_2\)/P-SAM, (e) SnO\(_2\)/C-SAM and (f) SnO\(_2\)/M-SAM as substrates. (g) XRD patterns of perovskite films on SnO\(_2\), SnO\(_2\)/P-SAM, SnO\(_2\)/C-SAM and SnO\(_2\)/M-SAM. (h,i) UPS spectra of SnO\(_2\) and SnO\(_2\)/M-SAM films. (j) Energy level diagram of FTO, SnO\(_2\), SnO\(_2\)/M-SAM, and perovskite.
The effect of M-SAM modification on the band structures was further studied by ultraviolet photoelectron spectroscopy (UPS) in Figure 1h,i and ultraviolet-visible spectrophotometer (UV-Vis) in Figure S6. The band-gaps of SnO$_2$ and SnO$_2$/M-SAM were 3.94 and 3.97 eV, respectively. The Fermi level ($-E_F = E_{\text{cutoff}} - 21.22$ eV) and the conduction band (CB) were both up-shifted with the M-SAM modification and thus coordinate the interface energy level arrangement. The CB of SnO$_2$ and SnO$_2$/M-SAM were $-6.39$ eV and $-5.52$ eV, respectively (the details are showed in Table S1). In addition, the transmittance of SnO$_2$ films was not affected by SAMS modification. Correspondingly, a better energy band alignment was achieved between ETL/perovskite, favoring efficient electron transport (Figure 1j) [26].

![Figure 2](https://example.com/figure2.png)

**Figure 2.** FTIR spectra of (a) SnO$_2$, SnO$_2$/P-SAM, SnO$_2$/C-SAM, P-SAM, and C-SAM films, (b) PbI$_2$, PbI$_2$/P-SAM, PbI$_2$/C-SAM, P-SAM, and C-SAM films. XPS spectra of (c) Sn 3d, and (d) O 1s for the pristine SnO$_2$, SnO$_2$/P-SAM, SnO$_2$/C-SAM and SnO$_2$/M-SAM films, (e) Pb 4f for the PbI$_2$, PbI$_2$/P-SAM, PbI$_2$/C-SAM and PbI$_2$/M-SAM films.

The interaction mechanism of P-SAM, C-SAM and M-SAM in the buried bottom interface was further explored (Figure 2). In Figure 2a, the Fourier transform infrared spectroscopy (FTIR) spectra shows the P-O vibration shifts from 1167.88 cm$^{-1}$ in pure P-SAM to 1175.17 cm$^{-1}$ of the SnO$_2$/P-SAM and the C-O vibration shifts from 1135.25 cm$^{-1}$ in pure C-SAM to 1129.93 cm$^{-1}$ of the SnO$_2$/C-SAM, confirming the interaction of P-SAM and C-SAM with SnO$_2$, respectively. Similarly, the interaction between the SAM and perovskites is shown in Figure 2b. It can be clearly seen from the moment of initial N-H stretching peak moves from 3162.40 (P-SAM) to 3107.96 cm$^{-1}$ (PbI$_2$/P-SAM) and from 3177.48 (C-
SAM) to 3166.48 cm$^{-1}$ (Pbl$_2$/C-SAM), respectively, confirming that both small molecules interact with PbI$_2$ [23]. The X-ray photoelectron spectroscopy (XPS) measurements was further studied and the effect of SAM on surface chemical environment was discussed. The Sn 3d peaks in the pure SnO$_2$ at 495.28 and 486.88 eV, corresponding to Sn 3d$_{3/2}$ and Sn 3d$_{5/2}$, respectively, shifted to higher binding energies after SAM modifications in Figure 2c (SnO$_2$/P-SAM: 495.40 and 486.98 eV, SnO$_2$/C-SAM: 495.38 and 486.97 eV, SnO$_2$/M-SAM: 495.44 and 487.02 eV). The results show that both P-SAM and C-SAM had chemical interactions with SnO$_2$ [27]. As shown in Figure 2d, two peaks fitted at 532.5 eV and 531.1 eV corresponded to the -OH on the surface of SnO$_2$ and the saturated lattice oxygen in the SnO$_2$ film. Compared with the pure SnO$_2$, the calculated areas of -OH in the modified SnO$_2$ are all reduced. This indicates that more chemisorbed off-lattice oxygen is transferred to the lattice oxygen, and that the oxygen atom in SnO$_2$ exists as $\text{O}^2^{-}$. The reduced -OH is beneficial for improving the electron transport and suppressing the nonradiative recombination [28]. Meanwhile, in Figure 2e, two peaks fitted at 143.14 and 138.31 eV of Pb 4f spectrum for pure PbI$_2$ film, corresponding to Pb 4f$_{5/2}$ and Pb 4f$_{7/2}$, respectively, shifted towards higher binding energies for all SAM-modified samples (SnO$_2$/P-SAM: 143.32 and 138.41 eV; SnO$_2$/C-SAM: 143.35 and 138.49 eV; SnO$_2$/M-SAM: 143.47 and 138.63 eV). The results indicate that the interaction occurs between P-SAM, C-SAM, M-SAM and perovskite.

To further investigate the effect of SAM layers on the carrier transport dynamics, steady-state photoluminescence (SSPL) and time-resolved photoluminescence (TRPL) tests were performed (Figure 3a–d). From the analysis of perovskite, the SnO$_2$/SAM/perovskite displays lower PL signals than that of the SnO$_2$/perovskite and the SnO$_2$/M-SAM/perovskite possesses the lowest PL intensity among the SAM-modified samples. The TRPL curves in Figure 3b exhibit how the average time constant ($\tau_{ave}$) of perovskite film on SnO$_2$, SnO$_2$/P-SAM, SnO$_2$/C-SAM and SnO$_2$/M-SAM decreased from 1.482 $\mu$s to 1.294 $\mu$s, and 1.142 $\mu$s and 1.056 $\mu$s, respectively [29]. The detailed carrier lifetime is listed in Table S2. The decreased PL intensity and TRPL lifetime indicates that P-SAM-, C-SAM- and M-SAM-modification inhibits non-radiative recombination due to the passivated interface defects of SnO$_2$ and the optimized perovskite grain quality [19]. In general, the fast decay process ($\tau_1$) is related to the charge extraction and transport, and the slow decay ($\tau_2$) is related to the radiative recombination of the bulk perovskites. The value of $\tau_1$ decreased from 0.020 $\mu$s (SnO$_2$/perovskite) to 0.013 $\mu$s (SnO$_2$/M-SAM/perovskite), which proves that M-SAM-modification is beneficial for the extraction of electrons at the buried interface. In addition, by comparing the SSPL and TRPL results of perovskite films’ deposition on the glass substrate without ETL (Figure 3c,d), the samples show a significantly opposite trend and the corresponding fitted results are presented in Table S3. The SSPL intensity and the average lifetime of the perovskite films grown on the modified glass were significantly improved, which is attributed to the passivation of interface defects and the optimized grain quality of perovskite [29,30]. Then, the effect of SAM on perovskite films was further studied by PL intensity imaging (Figures 3e,h and S7). Compared with the control films, a weaker PL emission was observed from the SnO$_2$/M-SAM/perovskite, which is consistent with the SSPL spectrum shown in Figure 3a. In addition, the SnO$_2$/M-SAM/perovskite film exhibited more a uniform PL emission in the substrate compared to the control. These results further prove that M-SAM-modified SnO$_2$ can passivate the defects on the surface of SnO$_2$ and reduce the non-radiative recombination at the interface to improve the performance of the device. Additionally, the corresponding carrier lifetimes were summarized in Tables S4 and S5.
In short, P-SAM, C-SAM, and M-SAM interlayers in the buried bottom exhibited strong interactions with SnO\textsubscript{2} and perovskite, and thus suppressed the surface defects and facilitated carrier transport. Therefore, the device structure of FTO/SnO\textsubscript{2}/SAM/perovskite/Spiro-OMeTAD/Au (Figure S8) was constructed to investigate the effect of SAM on photovoltaic performance. Figure S9 shows the statistical analysis of the PSCs performance on the devices with different molar ratios of P-SAM and C-SAM. The best PCE of the PSC was achieved at a ratio of 1:1 and the corresponding photocurrent density–voltage (J–V) curves under AM 1.5 illumination are presented in Figure 4a. The champion PCE of the device using M-SAM increased from 22.72% (control), 23.99% (with P-SAM), 23.56% (with C-SAM) to 24.69%. Compared with the control PSCs, the increase in PCE was mainly due to the obvious increase in $V_{OC}$ (from 1.12 to 1.16 V) and $J_{SC}$ (from 24.37 to 25.54 mA/cm\textsuperscript{2}). In addition to this, a laser-etched perovskite solar module (PSM) with an area of 4 × 4 cm\textsuperscript{2} and an aperture area of 12.25 cm\textsuperscript{2} were also made, and the related J–V curve is exhibited in Figure 4b. The PSMs with M-SAM-modifications achieved an excellent PCE of 18.57%, while the PCE of the control PSMs was only 16.07%. A stabilized photocurrent patterns of SnO\textsubscript{2}, SnO\textsubscript{2}/P-SAM, SnO\textsubscript{2}/C-SAM, and SnO\textsubscript{2}/M-SAM/perovskite films before and after aging at 60 °C and 40% relative humidity (RH). After 100 h of aging at 60 °C and 40% relative humidity (RH), the SnO\textsubscript{2}/M-SAM/perovskite film showed a much weaker additional δ-FAPbI\textsubscript{3} phase diffraction peak than that of the control sample; the result implies that the presence of M-SAM could effectively suppress the phase transition induced by an exposure to moisture, which is consistent with the results in Figure S11. It is therefore further proved that the M-SAM can improve the defects of the SnO\textsubscript{2}/Perovskite interface, and that a stable perovskite film provides an important guarantee for the stability of the later device.
SnO$_2$/M-SAM/perovskite film showed a much weaker additional δ-FAPbI$_3$ phase diffraction peak than that of the control sample; the result implies that the presence of M-SAM modifications had a reduced leakage current, ascribing to a lower trapping density and carrier recombination at the interface of SnO$_2$/M-SAM/perovskite films aged at $\approx$40%RH, $\sim$60 °C. It is therefore further proved that the M-SAM can passivate the defects (the parameters were listed in Table S7) [30]. The Nyquist impedance in Figure 5d shows that the recombination resistance ($R_{\text{rec}}$) (2117 $\Omega$) of the device with M-SAM is higher than the control (1201 $\Omega$), suggesting a reduced charge recombination at the ETL/PVK interface by M-SAM. Additionally, M-SAM-modified devices achieved higher extracted the built-in potentials ($V_{bi}$, 0.95 V) from Mott–Schottky plots (Figure 5e) compared to the control device (0.92 V). The enlarged $V_{bi}$ contributed to the higher $V_{OC}$, following the same trend of $V_{OC}$ values shown in the $J$–$V$ curves [30]. The dependence of $V_{OC}$ on light intensity ($P_{\text{light}}$) was fitted to obtain the ideality factor $n$ (Figure 5f). The M-SAM-modified PSCs possessed the lower $n$ value (1.58) compared to the control (1.93), indicating that the trap-assisted recombination of PSCs was significantly reduced after M-SAM treatment. It has been proven that using M-SAM as the buried interface has a positive effect on improving device performance.
work improves the device efficiency by mixing two complementary self-assembled small molecules to passivate ETL/perovskite interface defects while taking into account stable charge extraction and transport. Consequently, the champion PCE of 24.69% and $V_{OC}$ of 1.16 V were achieved. Meanwhile, a PCE of 18.57% was obtained for a 4 × 4 cm$^2$ (12.25 cm$^2$ aperture area) perovskite module. At the same time, more than 91% of the initial PCE was maintained after storage at 25 °C and 65 °C for 1500 h and 100 h under nitrogen atmosphere. This work improves the device efficiency by mixing two complementary self-assembled small molecules to passivate ETL/perovskite interface defects while taking into account stable improvements. This method can improve the passivation uniformity CBD SnO$_2$/C-SAM, and is simple and suitable for future commercialization. The reuse of M-SAM passivation solutions need to be further researched in future works.

4. Conclusions

Aiming at the passivation problem of surface defects commonly used in SnO$_2$ ETL, we developed a synergistic effect strategy by combining the strong anchoring ability of phosphonic acid (-H$_2$PO$_3$) in metal oxide surfaces and the better charge transfer ability of carboxylic acid (-COOH). At the bottom of the interface, the -H$_2$PO$_3$ in P-SAM was used to enhance the anchoring ability and the -COOH in C-SAM was used to transport carriers quickly. In addition, the molecules interacted with both SnO$_2$ from -H$_2$PO$_3$ and -COOH with Sn and perovskite from -NH$_2$ and Pb$^{2+}$, thus improving the energy level arrangement and quality of perovskite films. The (FAPbI$_3$)$_{0.992}$(MAPbBr$_3$)$_{0.008}$ PSCs with mixed SAM modification passivated the defect density and accelerated the charge extraction and transport. Consequently, the champion PCE of 24.69% and $V_{OC}$ of 1.16 V were achieved. Meanwhile, a PCE of 18.57% was obtained for a 4 × 4 cm$^2$ (12.25 cm$^2$ aperture area) perovskite module. At the same time, more than 91% of the initial PCE was maintained after storage at 25 °C and 65 °C for 1500 h and 100 h under nitrogen atmosphere. This work improves the device efficiency by mixing two complementary self-assembled small molecules to passivate ETL/perovskite interface defects while taking into account stable improvements. This method can improve the passivation uniformity CBD SnO$_2$ surface, and is simple and suitable for future commercialization. The reuse of M-SAM passivation solutions need to be further researched in future works.

Supplementary Materials: The following supporting information can be downloaded at: https://www.mdpi.com/article/10.3390/ma16237306/s1, Figure S1: Structural formula of (a) P-SAM and (b) C-SAM. Figure S2: SEM images of perovskite surface based on (a) SnO$_2$, (b) SnO$_2$/P-SAM SnO$_2$, (c) SnO$_2$/C-SAM SnO$_2$ and (d) SnO$_2$/M-SAM. The perovskite grain size of (e) SnO$_2$, (f) SnO$_2$/P-SAM SnO$_2$, (g) SnO$_2$/C-SAM SnO$_2$ and (h) SnO$_2$/M-SAM; Figure S3. Contact angles of (a) SnO$_2$, (b) SnO$_2$/P-SAM, (c) SnO$_2$/C-SAM, and (d) SnO$_2$/M-SAM as substrates; Figure S4. SEM images for five different locations of the 4 × 4 cm$^2$ perovskite film deposited on SnO$_2$ substrate. The scale bar is 10 µm. The distribution of the grain size is plotted in histogram for comparison; Figure S5. SEM images for five different locations of the 4 × 4 cm$^2$ perovskite film deposited on SnO$_2$/M-SAM substrate. The scale bar is 10 µm. The distribution of the grain size is plotted in histogram for comparison; Figure S6. (a) Transmission electron microscopy (TEM) images of (a, b) P-SAM and (c, d) C-SAM.
and absorption spectra FTO, SnO\textsubscript{2} SnO\textsubscript{2}/P-SAM, SnO\textsubscript{2}/C-SAM and SnO\textsubscript{2}/M-SAM films. (b) Tauc plots of pristine SnO\textsubscript{2} and SnO\textsubscript{2}/M-SAM films; Figure S7. PL intensity imaging of SnO\textsubscript{2}/perovskite and SnO\textsubscript{2}/M-SAM/perovskite films (size of 0.02 × 0.02 mm\textsuperscript{2}); Figure S8. PSCs with the structure of FTO/SnO\textsubscript{2}/SAM/Perovskite/Spiro-OMeTAD/Au; Figure S9. The PSCs performance (a) V\textsubscript{OC}, (b) J\textsubscript{SC}, (c) FF and (d) PCE of the devices with different molar ratios of P-SAM and C-SAM; Figure S10. J–V curves for control and M-SAM modified PSCs under reverse and forward scans (at illumination of 100 mW/cm\textsuperscript{2}); Figure S11. XRD patterns for (a) SnO\textsubscript{2}/perovskite and (b) SnO\textsubscript{2}/M-SAM/perovskite films aged at a RH ≈ 40%, T = 25 °C; Table S1: Table S1. Summarized parameters of energy band structure for SnO\textsubscript{2}, SnO\textsubscript{2}/M-SAM (on FTO substrates); Table S2. Fitted parameters of the TRPL curves for SnO\textsubscript{2}/perovskite SnO\textsubscript{2}/P-SAM/perovskite, SnO\textsubscript{2}/C-SAM/perovskite and SnO\textsubscript{2}/M-SAM/perovskite films (on glass substrates); Table S3. Fitted parameters of the TRPL curves for glass/perovskite, glass/P-SAM/perovskite, glass/C-SAM/perovskite and glass/M-SAM/perovskite films; Table S4. Fitted parameters of the PL intensity imaging for SnO\textsubscript{2}/perovskite SnO\textsubscript{2}/P-SAM/perovskite, SnO\textsubscript{2}/C-SAM/perovskite and SnO\textsubscript{2}/M-SAM/perovskite films (on glass substrates); Table S5. Fitted parameters of the PL intensity imaging for SnO\textsubscript{2}/perovskite SnO\textsubscript{2}/M-SAM/perovskite films (on glass substrates); Table S6. Photovoltaic parameters for SnO\textsubscript{2} and M-SAM modified PSCs under reverse scan and forward scan (HI = (PCE\textsubscript{forward}–PCE\textsubscript{reverse})/PCE\textsubscript{forward}); Table S7. Calculated parameters and trap densities (N\textsubscript{trap}) of perovskite films grown on SnO\textsubscript{2} and SnO\textsubscript{2}/M-SAM substrates for electron only devices; Table S8. The modification of CBD SnO\textsubscript{2} for getting the improved performance of PSCs are listed below. References [31,32] are cited in the Supplementary Materials.

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